



P-Channel NexFET™ Power MOSFET

Check for Samples: CSD25213W10

FEATURES

- Ultra Low Qg and Qgd
- Small Footprint 1mm x 1mm
- Low Profile 0.62mm Height
- Pb Free
- Gate-Source Voltage Clamp
- Gate ESD Protection
- RoHS Compliant
- Halogen Free

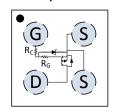
APPLICATIONS

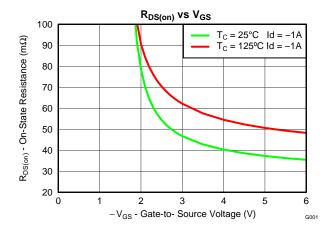
- Battery Management
- Load Switch
- Battery Protection

DESCRIPTION

The device has been designed to deliver the lowest on resistance and gate charge in the smallest outline possible with excellent thermal characteristics in an ultra low profile.

Top View





PRODUCT SUMMARY

V _{DS}	Drain to Source Voltage	-20	V	
Q_g	Gate Charge Total (4.5V)	2.2	nC	
Q_{gd}	Gate Charge Gate to Drain	0.14	nC	
R _{DS(on)}	Drain to Source On	$V_{GS} = -2.5V$	54	mΩ
	Resistance	V _{GS} = -4.5V	39	mΩ
$V_{GS(th)}$	Threshold Voltage	-0.85	٧	

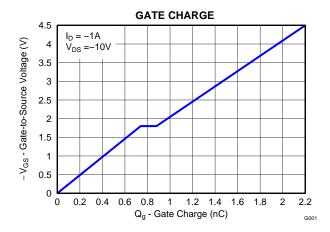
ORDERING INFORMATION

Device	Package	Media	Qty	Ship	
CSD25213W10	1 x 1 Wafer Level Package	7-inch reel	3000	Tape and Reel	

ABSOLUTE MAXIMUM RATINGS

T _A = 25°C	unless otherwise stated	VALUE	UNIT
V_{DS}	Drain to Source Voltage	-20	٧
V _{GS}	Gate to Source Voltage	-6.0	V
I _D	Continuous Drain Current, $T_A = 25^{\circ}C^{(1)}$	-1.6	Α
I_{DM}	Pulsed Drain Current, T _A = 25°C ⁽²⁾	-16	Α
I _G	Continuous Gate Clamp Current ⁽³⁾	-5	mA
P_D	Power Dissipation ⁽¹⁾	1	W
T _J , T _{STG}	Operating Junction and Storage Temperature Range	-55 to 150	°C

- (1) $R_{\theta JA} = 75^{\circ}\text{C/W}$ on 1in^2 Cu (2 oz.) on 0.060" thick FR4 PCB.
- (2) Pulse width ≤300µs, duty cycle ≤2%
- (3) Limited by gate resistance.





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ELECTRICAL CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static Ch	aracteristics					
BV _{DSS}	Drain to Source Voltage	$V_{GS} = 0V, I_{D} = -250\mu A$	-20			V
BV _{GSS}	Gate to Source Voltage;	$V_{DS} = 0V, I_{G} = -250\mu A$	-6.0			V
I _{DSS}	Drain to Source Leakage Current	V _{GS} = 0V, V _{DS} = -10V			-1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{DS} = 0V$, $V_{GS} = -6V$			-100	nA
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.60	-0.85	-1.10	V
D	Dunin to Course On Besistance	$V_{GS} = -2.5V, I_D = -1A$		54	67	mΩ
R _{DS(on)}	Drain to Source On Resistance	$V_{GS} = -4.5V, I_D = -1A$		39	47	mΩ
9 _{fs}	Transconductance	$V_{DS} = -10V, I_{D} = -1A$		6.2		S
Dynamic	Characteristics					
C _{ISS}	Input Capacitance			368	478	pF
Coss	Output Capacitance	$V_{GS} = 0V, V_{DS} = -10V, f = 10kHz$		148	192	pF
C _{RSS}	Reverse Transfer Capacitance			7.8	10.1	pF
R _G	Series Gate Resistance			20		Ω
R _C	Series Clamp Resistance			5000		Ω
Qg	Gate Charge Total (-4.5V)			2.2	2.9	nC
Q _{gd}	Gate Charge Gate to Drain	V _{DS} = -10V, I _D = -1A		0.14		nC
Q _{gs}	Gate Charge Gate to Source			0.74		nC
Q _{g(th)}	Gate Charge at Vth			0.43		nC
Q _{OSS}	Output Charge	$V_{DS} = -10V, V_{GS} = 0V$		2.5		nC
t _{d(on)}	Turn On Delay Time			510		ns
t _r	Rise Time	$V_{DS} = -10V, V_{GS} = -2.5V, I_D = -1A$		520		ns
t _{d(off)}	Turn Off Delay Time	$R_G = 10\Omega$		1000		ns
t _f	Fall Time			970		ns
Diode Ch	naracteristics					
V _{SD}	Diode Forward Voltage	$I_S = -1A$, $V_{GS} = 0V$		-0.77	-1	V
Q _{rr}	Reverse Recovery Charge	$V_{DS} = -10V, I_F = -1A,$ di/dt = 200A/ μ s		4.0		nC
t _{rr}	Reverse Recovery Time	$V_{DS} = -10V, I_F = -1A,$ di/dt = 200A/ μ s		11		ns

THERMAL CHARACTERISTICS

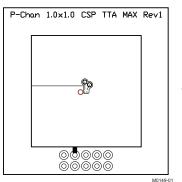
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	PARAMETER	MIN	TYP	MAX	UNIT
D	Junction to Ambient Thermal Resistance ⁽¹⁾		75		°C/W
$R_{\theta JA}$	Junction to Ambient Thermal Resistance ⁽²⁾		265		°C/W

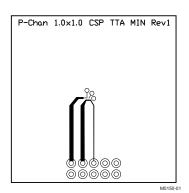
- (1) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.
 (2) Device mounted on FR4 material with minimum Cu mounting area.

Product Folder Links: CSD25213W10





Max $R_{\theta JA} = 90^{\circ}C/W$ when mounted on 1inch² of 2 oz. Cu.



Max $R_{\theta JA} = 333^{\circ} C/W$ when mounted on minimum pad area of 2 oz. Cu.

TYPICAL MOSFET CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

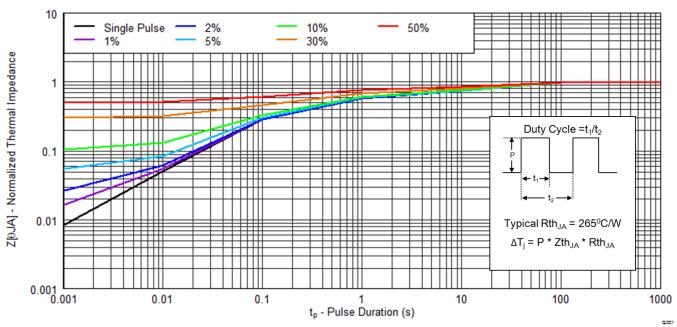


Figure 1. Transient Thermal Impedance

Product Folder Links: CSD25213W10

1.1

1

0.9

0.8

0.7

0.6

0.5 -75

-V_{GS(th)} - Threshold Voltage (V)



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TYPICAL MOSFET CHARACTERISTICS (continued)

(T_A = 25°C unless otherwise stated)

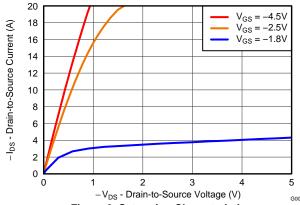


Figure 2. Saturation Characteristics

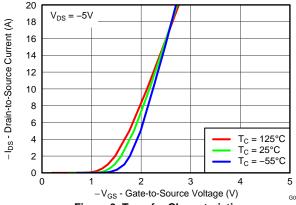


Figure 3. Transfer Characteristics

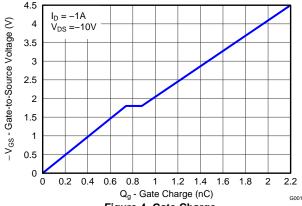
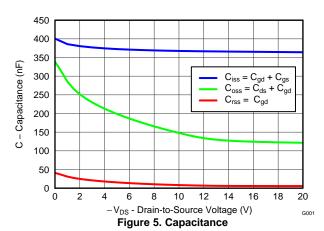


Figure 4. Gate Charge



100 $T_C = 25^{\circ}C$ Id = -1A $R_{DS(on)}$ - On-State Resistance $(m\Omega)$ 90 $T_C = 125^{\circ}C \text{ Id} = -1A$ 80 70 60 50 40 30 20 3

Figure 6. Threshold Voltage vs. Temperature

125

175

75

T_C - Case Temperature (°C)

 $I_{D} = -250uA$

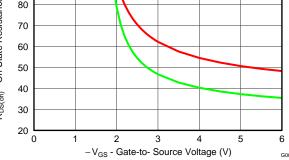


Figure 7. On-State Resistance vs. Gate-to-Source Voltage

-25

25



TYPICAL MOSFET CHARACTERISTICS (continued)

(T_A = 25°C unless otherwise stated)

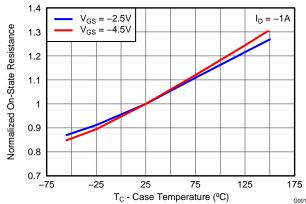


Figure 8. Normalized On-State Resistance vs. Temperature

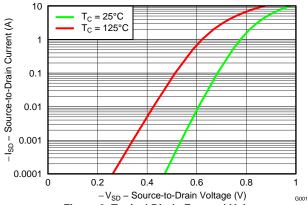


Figure 9. Typical Diode Forward Voltage

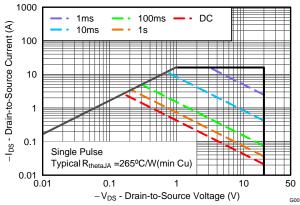


Figure 10. Maximum Safe Operating Area

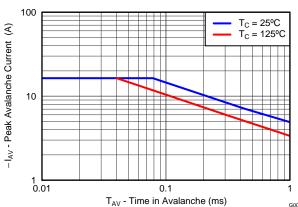


Figure 11. Single Pulse Unclamped Inductive Switching

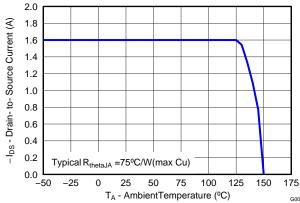


Figure 12. Maximum Drain Current vs. Temperature

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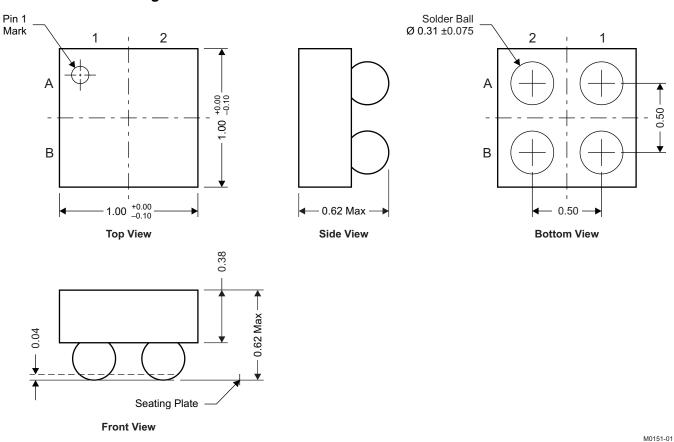
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TEXAS INSTRUMENTS

MECHANICAL DATA

CSD25213W10 Package Dimensions

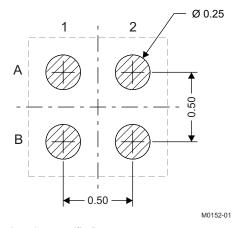


NOTE: All dimensions are in mm (unless otherwise specified)

Pin Configuration Table

<u> </u>							
POSITION	DESIGNATION						
A1	Gate						
B1	Drain						
A2, B2	Source						

Land Pattern Recommendation



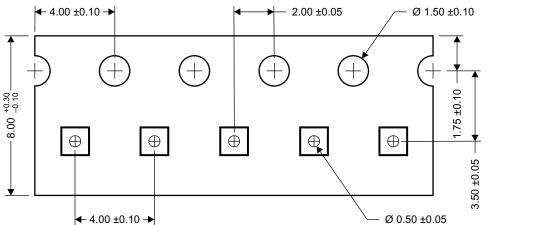
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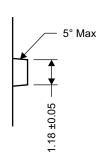
NOTE: All dimensions are in mm (unless otherwise specified)

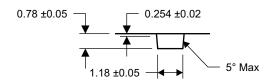
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Tape and Reel Information







M0153-01

- (1) All dimensions are in mm (unless otherwise specified)
- (2) Pin 1 will be oriented in the top left quadrant of the tape enclosure (closest to the carrier tape sprocket holes).



PACKAGE OPTION ADDENDUM

17-Jul-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	S S		Eco Plan	Lead/Ball Finish	MSL Peak Temp Op Temp (°C)		Device Marking	Samples
	(1)		Drawing		Qty	(2)		(3)		(4/5)	
CSD25213W10	ACTIVE	DSBGA	YZB	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-55 to 150	213	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD25213W10	DSBGA	YZB	4	3000	180.0	8.4	1.06	1.06	0.69	4.0	8.0	Q1

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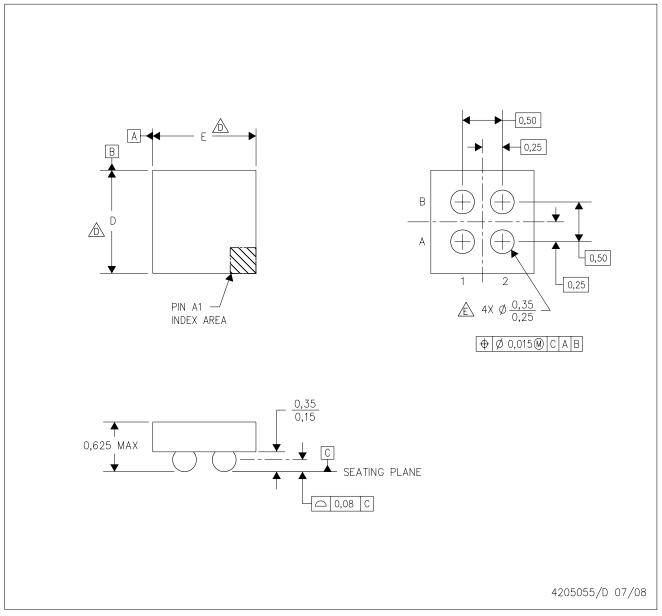


*All dimensions are nominal

Device	Device Package Type		Package Drawing Pins		Length (mm)	Width (mm)	Height (mm)	
CSD25213W10	DSBGA	YZB	4	3000	182.0	182.0	17.0	

YZB (S-XBGA-N4)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- Devices in YZB package can have dimension D ranging from 0.94 to 1.65 mm and dimension E ranging from 0.94 to 1.65 mm.

 To determine the exact package size of a particular device, refer to the device datasheet or contact a local TI representative.
- E. Reference Product Data Sheet for array population. 2 x 2 matrix pattern is shown for illustration only.
- F. This package contains lead—free balls. Refer to YEB (Drawing #4204178) for tin—lead (SnPb) balls.



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